

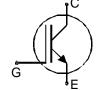
IGBT³ Chip

FEATURES:

- 1700V Trench + Field Stop technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- · easy paralleling

This chip is used for:

power module



Applications:

• drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC186T170R3	1700V	150A	13.63 x 13.63 mm ²	sawn on foil	Q67050- A4148-A001

MECHANICAL PARAMETER:

Raster size	13.63 x 13.63		
Emitter pad size	8 x (5.62 x 2.71)		
Gate pad size	1.12 x 1.12		
Area total / active	185.8 / 149.7	mm ²	
Thickness	190	μm	
Wafer size	150	mm	
Flat position	90	grd	
Max.possible chips per wafer	69 pcs		
Passivation frontside	Photoimide		
Emitter metalization	3200 nm AlSiCu		
Collector metalization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding		
Die bond	electrically conductive glue or solder		
Wire bond	Al, <500μm		
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm		
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C		



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1700	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	450	Α
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Turumeter			min.	typ.	max.	0
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0 V , I_{C} = 4 mA	1700			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =150A	1.6	2	2.4	V
Gate-emitter threshold voltage	V _{GE(th)}	I _C =6mA , V _{GE} =V _{CE}	5.2	5.8	6.4	
Zero gate voltage collector current	I _{CES}	V _{CE} =1700V , V _{GE} =0V			8.2	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			600	nA
Integrated gate resistor	R _{Gint}			5		Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol Conditions	Value			Unit	
raiailietei	Symbol	Conditions	min.	typ.	max.	Onne
Input capacitance	Ciss	V _{CE} =25V,		13196		pF
Output capacitance	Coss	$V_{GE}=0V$,		549		
Reverse transfer capacitance	Crss	f=1MHz		438		

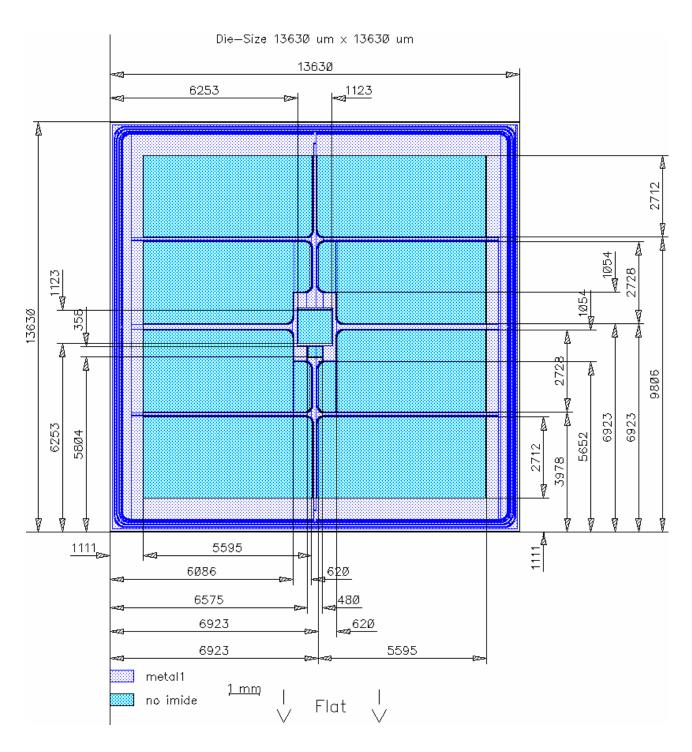
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions 1)	Value			Unit
- arameter			min.	typ.	max.	Oiiit
Turn-on delay time	$t_{d(on)}$	T _j =125°C		0.30		μs
Rise time	t _r	V _{CC} =900V, I _C =150A, V _{GE} =-15/15V,		0.066		
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}} = -15/15 \text{V},$		1		
Fall time	t_{f}	$R_{\rm G}$ = 9.1 Ω		0.30		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	tbd					
DESCRIPTION:						
AQL 0,65 for visual inspection according to failure catalog						
Electrostatic Discharge Sensitive Device according to MIL-STD 883						
Test-Normen Villach/Prüffeld						

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